- **Independent Registers for A and B Buses**
- **Multiplexed Real-Time and Stored Data**
- **Inverting Data Paths**
- **Flow-Through Architecture Optimizes PCB Layout**
- **Center-Pin V_{CC} and GND Configurations Minimize High-Speed Switching Noise**
- ***EPIC*** ™ **(Enhanced-Performance Implanted CMOS) 1-μm Process**
- **500-mA Typical Latch-Up Immunity at 125°C**
- **Package Options Include Plastic Small-Outline Packages and Standard Plastic 300-mil DIPs**

DW OR NT PACKAGE
(TOP VIEW)

$\overline{OE}$	1		28	CLKAB
A1	2		27	SAB
A2	3		26	B1
A3	4		25	B2
A4	5		24	B3
GND	6		23	B4
GND	7		22	V_{CC}
GND	8		21	V_{CC}
GND	9		20	B5
A5	10		19	B6
A6	11		18	B7
A7	12		17	B8
A8	13		16	CLKBA
DIR	14		15	SBA
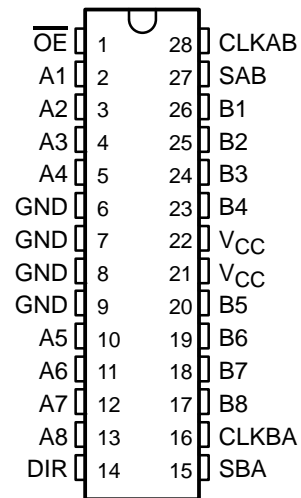
description

The 74AC11648 consists of bus transceiver circuits, D-type flip-flops, and control circuitry arranged for multiplexed transmission of data directly from the input bus or from the internal registers. Data on the A or B bus is clocked into the registers on the low-to-high transition of the appropriate clock (CLKAB or CLKBA) input. Figure 1 illustrates the four fundamental bus-management functions that can be performed with the 74AC11648.

Output-enable ($\overline{OE}$) and direction-control (DIR) inputs are provided to control the transceiver functions. In the transceiver mode, data present at the high-impedance port may be stored in either register or in both.

The select-control (SAB and SBA) inputs can multiplex stored and real-time (transparent mode) data. The direction control (DIR) determines which bus will receive data when $\overline{OE}$ is low. In the isolation mode ($\overline{OE}$ high), A data may be stored in one register and/or B data may be stored in the other register.

When an output function is disabled, the input function is still enabled and may be used to store and transmit data. Only one of the two buses, A or B, may be driven at a time.

The 74AC11648 is characterized for operation from −40°C to 85°C.

TEXAS INSTRUMENTS

1	14	28	16	27	15
$\overline{\text{OE}}$	DIR	CLKAB	CLKBA	SAB	SBA
L	L	X	X	X	L

REAL-TIME TRANSFER
BUS B TO BUS A

1	14	28	16	27	15
$\overline{\text{OE}}$	DIR	CLKAB	CLKBA	SAB	SBA
L	H	X	X	L	X

REAL-TIME TRANSFER
BUS A TO BUS B

1	14	28	16	27	15
$\overline{\text{OE}}$	DIR	CLKAB	CLKBA	SAB	SBA
X	X	↑	X	X	X
X	X	X	↑	X	X
H	X	↑	↑	X	X

STORAGE FROM
A, B, OR A AND B

1	14	28	16	27	15
$\overline{\text{OE}}$	DIR	CLKAB	CLKBA	SAB	SBA
L	L	X	L	X	H
L	H	L	X	H	X

TRANSFER STORED DATA
TO A AND/OR B

Figure 1. Bus-Management Functions

TEXAS
INSTRUMENTS
POST OFFICE BOX 655303 ● DALLAS, TEXAS 75265

FUNCTION TABLE

INPUTS						DATA I/O		OPERATION OR FUNCTION
$\overline{OE}$	DIR	CLKAB	CLKBA	SAB	SBA	A1 THRU A8	B1 THRU B8	
X	X	↑	X	X	X	Input	Unspecified[†]	Store A, B unspecified[†]
X	X	X	↑	X	X	Unspecified[†]	Input	Store B, A unspecified[†]
H	X	↑	↑	X	X	Input	Input	Store A and B data
H	X	L	L	X	X	Input disabled	Input disabled	Isolation, hold storage
L	L	X	X	X	L	Output	Input	Real-time $\overline{B}$ data to A bus
L	L	X	L	X	H	Output	Input	Stored $\overline{B}$ data to A bus
L	H	X	X	L	X	Input	Output	Real-time $\overline{A}$ data to B bus
L	H	L	X	H	X	Input	Output	Stored $\overline{A}$ data to B bus

[†] The data output functions may be enabled or disabled by various signals at the $\overline{OE}$ and DIR inputs. Data input functions are always enabled; i.e., data at the bus pins will be stored on every low-to-high transition of the clock inputs.
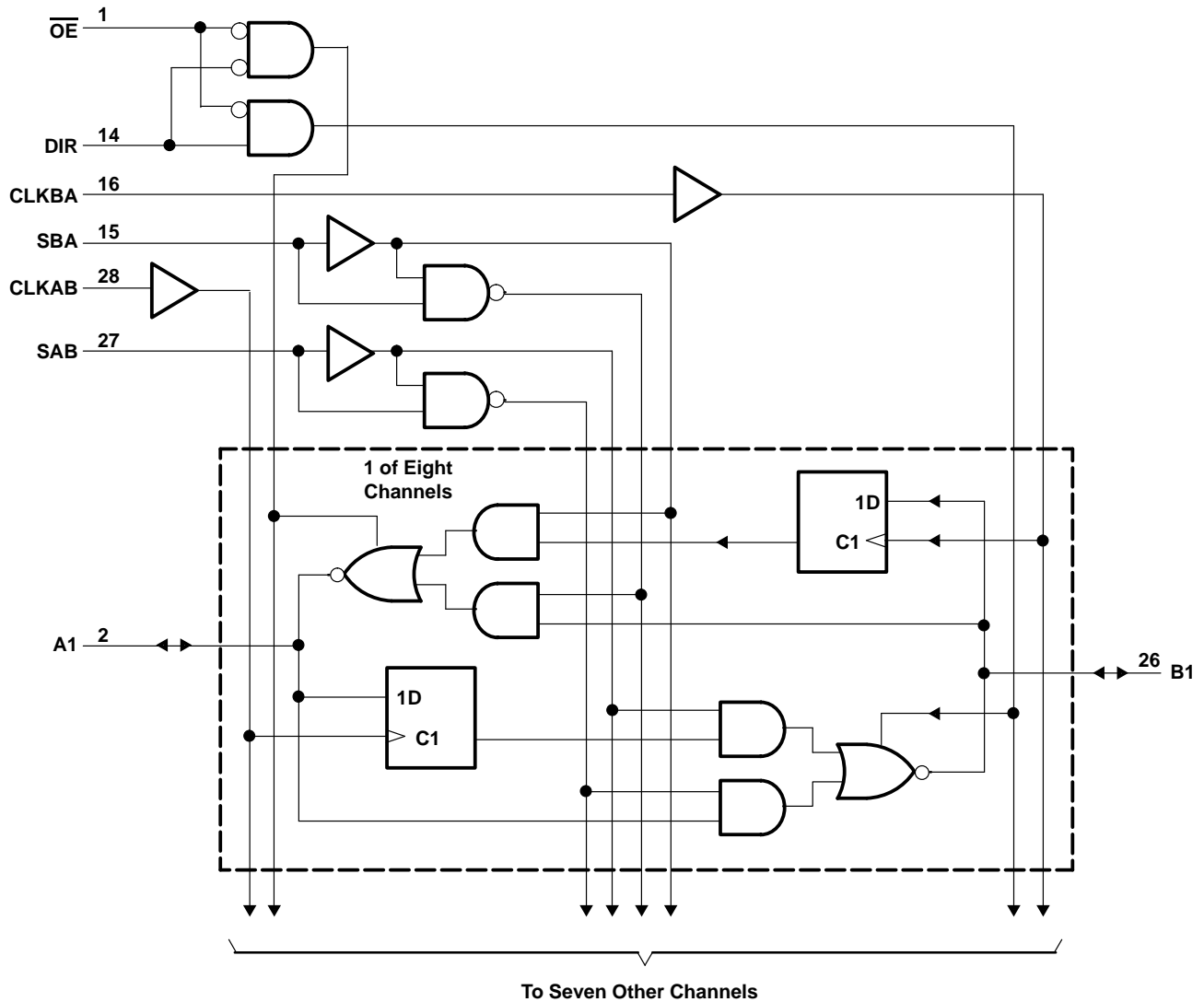
logic symbol[‡]
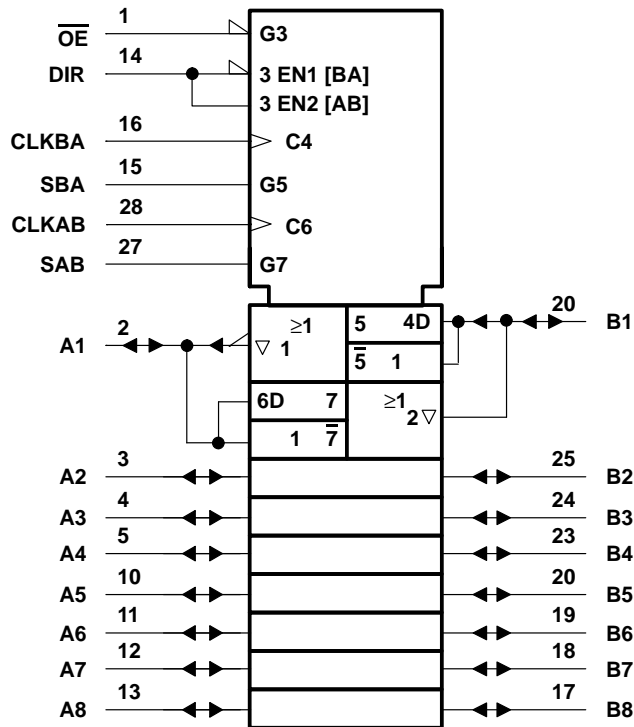
[‡] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

74AC11648
OCTAL BUS TRANSCEIVER AND REGISTER
WITH 3-STATE OUTPUTS
SCAS114 – MARCH 1990 – REVISED APRIL 1993

logic diagram (positive logic)

To Seven Other Channels

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V_{CC} .... −0.5 V to 7 V
Input voltage range, V_I (see Note 1) .... −0.5 V to V_{CC} + 0.5 V
Output voltage range, V_O (see Note 1) .... −0.5 V to V_{CC} + 0.5 V
Input clamp current, I_{IK} (V_I < 0 or V_I > V_{CC}) .... ±20 mA
Output clamp current, I_{OK} (V_O < 0 or V_O > V_{CC}) .... ±50 mA
Continuous output current, I_O (V_O = 0 to V_{CC}) .... ±50 mA
Continuous current through V_{CC} or GND .... ±200 mA
Storage temperature range .... −65°C to 150°C

† Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

**TEXAS
INSTRUMENTS**

recommended operating conditions

			MIN	NOM	MAX	UNIT
V_{CC}	Supply voltage		3	5	5.5	V
V_{IH}	High-level input voltage	V_{CC} = 3 V	2.1			V
		V_{CC} = 4.5 V	3.15			
		V_{CC} = 5.5 V	3.85			
V_{IL}	Low-level input voltage	V_{CC} = 3 V			0.9	V
		V_{CC} = 4.5 V			1.35	
		V_{CC} = 5.5 V			1.65	
V_I	Input voltage		0		V_{CC}	V
V_O	Output voltage		0		V_{CC}	V
I_{OH}	High-level output current	V_{CC} = 3 V			−4	mA
		V_{CC} = 4.5 V			−24	
		V_{CC} = 5.5 V			−24	
I_{OL}	Low-level output current	V_{CC} = 3 V			12	mA
		V_{CC} = 4.5 V			24	
		V_{CC} = 5.5 V			24	
$\Delta t/\Delta v$	Input transition rise or fall rate		0		10	ns/V
T_A	Operating free-air temperature		−40		85	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS	V_{CC}	T_A = 25°C			MIN	MAX	UNIT
				MIN	TYP	MAX			
V_{OH}		I_{OH} = − 50 µA	3 V	2.9			2.9		V
			4.5 V	4.4			4.4		
			5.5 V	5.4			5.4		
		I_{OH} = − 4 mA	3 V	2.58			2.48		
		I_{OH} = − 24 mA	4.5 V	3.94			3.8		
			5.5 V	4.94			4.8		
		I_{OH} = −75 mA†	5.5 V				3.85		
V_{OL}		I_{OL} = 50 µA	3 V			0.1		0.1	V
			4.5 V			0.1		0.1	
			5.5 V			0.1		0.1	
		I_{OL} = 12 mA	3 V			0.36		0.44	
		I_{OL} = 24 mA	4.5 V			0.36		0.44	
			5.5 V			0.36		0.44	
		I_{OL} = 75 mA†	5.5 V					1.65	
I_I	Control inputs	V_I = V_{CC} or GND	5.5 V		±0.1			±1	µA
I_{OZ}‡	A or B ports	V_O = V_{CC} or GND	5.5 V		±0.5			±5	µA
I_{CC}		V_I = V_{CC} or GND, I_O = 0	5.5 V		8			80	µA
C_i	Control inputs	V_I = V_{CC} or GND	5 V		4.5				pF
C_{io}	A or B ports	V_O = V_{CC} or GND	5 V		12				pF

† Not more than one output should be tested at a time, and the duration of the test should not exceed 10 ms.
‡ For I/O ports, the parameter I_{OZ} includes the input leakage current.

Texas
INSTRUMENTS

OCTAL BUS TRANSCEIVER AND REGISTER
WITH 3-STATE OUTPUTS

SCAS114 – MARCH 1990 – REVISED APRIL 1993

timing requirements over recommended operating free-air temperature range, V_{CC} = 3.3 V $\pm$ 0.3 V (unless otherwise noted) (see Figure 2)

		T_A = 25°C		MIN	MAX	UNIT
		MIN	MAX			
f_{clock}	Clock frequency	0	40	0	40	MHz
t_w	Pulse duration, CLK high or low	12.5		12.5		ns
t_{su}	Setup time, A or B before CLKAB↑ or CLKBA↑	6.5		6.5		ns
t_h	Hold time, A or B after CLKAB↑ or CLKBA↑	0		0		ns

timing requirements over recommended operating free-air temperature range, V_{CC} = 5 V $\pm$ 0.5 V (unless otherwise noted) (see Figure 2)

		T_A = 25°C		MIN	MAX	UNIT
		MIN	MAX			
f_{clock}	Clock frequency	0	90	0	90	MHz
t_w	Pulse duration, CLK high or low	5.6		5.6		ns
t_{su}	Setup time, A or B before CLKAB↑ or CLKBA↑	4.5		4.5		ns
t_h	Hold time, A or B after CLKAB↑ or CLKBA↑	1		1		ns

switching characteristics over recommended operating free-air temperature range, V_{CC} = 3.3 V $\pm$ 0.3 V (unless otherwise noted) (see Figure 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	T_A = 25°C			MIN	MAX	UNIT
			MIN	TYP	MAX			
f_{max}			40			40		MHz
t_{PLH}	A or B	B or A	3	8.7	12.6	3	14.3	ns
t_{PHL}			3.8	9.3	14.4	3.8	15.9	
t_{PZH}	$\overline{OE}$	A or B	5	11.1	17.2	5	19.4	ns
t_{PZL}			5.2	12.8	20.5	5.2	23	
t_{PHZ}	$\overline{OE}$	A or B	4.1	7.2	9.9	4.1	10.6	ns
t_{PLZ}			3.7	6.5	9.1	3.7	9.7	
t_{PLH}	CLKBA or CLKAB	A or B	4.3	10.1	15.6	4.3	17.6	ns
t_{PHL}			5.2	11.5	17.6	5.2	19.4	
t_{PLH}	SBA or SAB[†] (A or B high)	A or B	3.7	9.1	14.1	3.7	15.8	ns
t_{PHL}			4.5	10.3	15.9	4.5	17.4	
t_{PLH}	SBA or SAB[†] (A or B low)	A or B	3.2	8.6	13.6	3.2	15.3	ns
t_{PHL}			4.6	10.3	15.6	4.6	17.1	
t_{PZH}	DIR	A or B	4.9	11.6	18.2	4.9	20.6	ns
t_{PZL}			5.2	14.2	21.6	5.2	24.3	
t_{PHZ}	DIR	A or B	3.8	7.1	10.1	3.8	10.9	ns

† These parameters are measured with the internal output state of the storage register opposite to that of the bus input.

TEXAS
INSTRUMENTS

POST OFFICE BOX 655303 ● DALLAS, TEXAS 75265

**switching characteristics over recommended operating free-air temperature range,
V_{CC} = 5 V ± 0.5 V (unless otherwise noted) (see Figure 2)**

PARAMETER	FROM (INPUT)	TO (OUTPUT)	T_A = 25°C			MIN	MAX	UNIT
			MIN	TYP	MAX			
f_{max}			90			90		MHz
t_{PLH}	A or B	B or A	2.6	5.6	8.3	2.6	9.5	ns
t_{PHL}			3.2	6.4	9.4	3.2	10.6	
t_{PZH}	$\overline{OE}$	A or B	4.2	7.8	11.3	4.2	12.8	ns
t_{PZL}			4.1	8.1	12	4.1	13.6	
t_{PHZ}	$\overline{OE}$	A or B	3.8	6.3	8.6	3.8	9.2	ns
t_{PLZ}			3.5	5.7	7.8	3.5	8.4	
t_{PLH}	CLKBA or CLKAB	A or B	3.6	6.9	10	3.6	11.4	ns
t_{PHL}			4.3	8	11.4	4.3	12.8	
t_{PLH}	SBA or SAB† (A or B high)	A or B	3.1	6.2	9.2	3.1	10.4	ns
t_{PHL}			3.8	7.6	10.4	3.8	11.6	
t_{PLH}	SBA or SAB† (A or B low)	A or B	2.8	6.1	8.9	2.8	10.1	ns
t_{PHL}			3.8	7.3	10.4	3.8	11.6	
t_{PZH}	DIR	A or B	4	8	11.9	4	13.4	ns
t_{PZL}			4.1	8.4	12.7	4.1	14.4	
t_{PHZ}	DIR	A or B	3.5	6.1	8.5	3.5	9.1	ns
t_{PLZ}			3.4	5.9	7.8	3.4	8.4	

operating characteristics, V_{CC} = 5 V, T_A = 25°C

PARAMETER		TEST CONDITIONS		TYP	UNIT
C_{pd} Power dissipation capacitance per transceiver	Outputs enabled	C_L = 50 pF,	f = 1 MHz	66	pF
	Outputs disabled			17	

PARAMETER MEASUREMENT INFORMATION
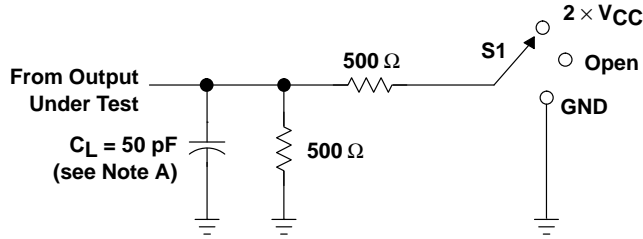
TEST	S1
t_{PLH}/t_{PHL}	Open
t_{PLZ}/t_{PZL}	$2 \times V_{CC}$
t_{PHZ}/t_{PZH}	GND

LOAD CIRCUIT
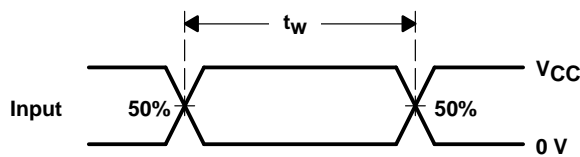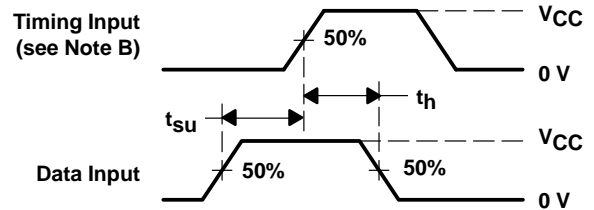
VOLTAGE WAVEFORMS
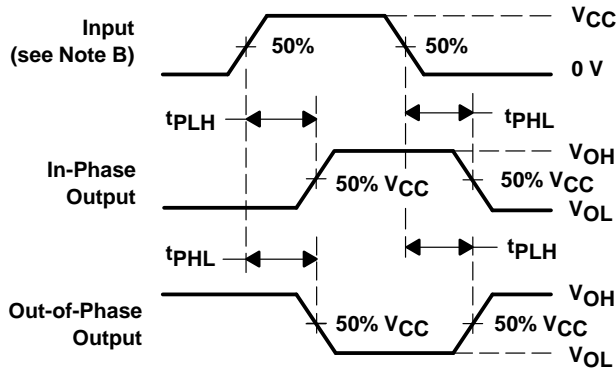
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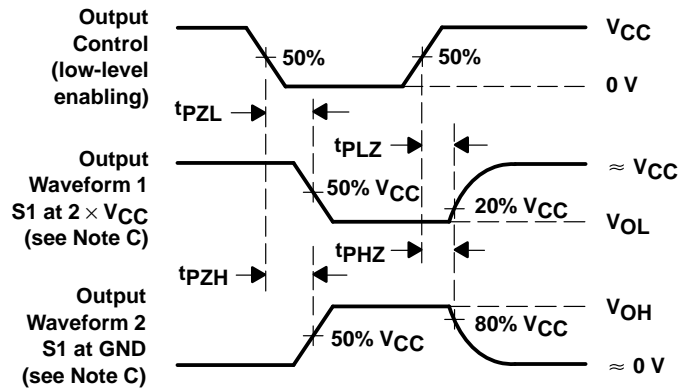
VOLTAGE WAVEFORMS

VOLTAGE WAVEFORMS

NOTES: A. C_L includes probe and jig capacitance.
  B. All input pulses are supplied by generators having the following characteristics: PRR ≤ 10 MHz, Z_O = 50 Ω, t_r = 3 ns, t_f = 3 ns.
  C. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control.
    Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
  D. The outputs are measured one at a time with one input transition per measurement.

Figure 2. Load Circuit and Voltage Waveforms